Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/990,343	IIJIMA ET AL.
Examiner	Art Unit

2627

TAN X. DINH

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST (see search history printout)	3/28/2006	T.D	